

The S-8250B Series is a protection IC for 1-cell lithium-ion / lithium polymer rechargeable batteries and includes high-accuracy voltage detection circuits and delay circuits.

The S-8250B Series is suitable for protecting 1-cell lithium-ion / lithium polymer rechargeable battery packs from overcharge, overdischarge and overcurrent. By adjusting power supply voltage dependency of discharge overcurrent detection voltage in accordance with ON resistance of the charge-discharge control FET, the S-8250B Series realizes high-accuracy discharge overcurrent detection.

## ■ Features

- High-accuracy discharge overcurrent detection circuit
 

Discharge overcurrent detection voltage	0.050 V to 0.150 V (1 mV step)	Accuracy $\pm 10$ mV ( $T_a = +25^\circ\text{C}$ )
(Power supply voltage dependency can be set in accordance with ON resistance of the charge-discharge control FET.)		
- High-accuracy voltage detection circuit
 

Overcharge detection voltage	4.100 V to 4.600 V (5 mV step)	Accuracy $\pm 20$ mV ( $T_a = +25^\circ\text{C}$ )
		Accuracy $\pm 25$ mV ( $T_a = -10^\circ\text{C}$ to $+60^\circ\text{C}$ )
Overcharge release voltage	3.700 V to 4.600 V <sup>*1</sup>	Accuracy $\pm 30$ mV
Overdischarge detection voltage	2.000 V to 2.800 V (10 mV step)	Accuracy $\pm 50$ mV
Overdischarge release voltage	2.000 V to 3.000 V <sup>*2</sup>	Accuracy $\pm 100$ mV
Load short-circuiting detection voltage	0.250 V to 0.500 V (50 mV step)	Accuracy $\pm 50$ mV
Charge overcurrent detection voltage	-0.200 V to -0.025 V (25 mV step)	Accuracy $\pm 15$ mV
- Detection delay times are generated only by an internal circuit (External capacitors are unnecessary).
- 0 V battery charge function is selectable: Available, unavailable
- Power-down function is selectable: Available, unavailable
- Release condition of discharge overcurrent status is selectable: Load disconnection, charger connection
- High-withstand voltage: VM pin and CO pin: Absolute maximum rating 28 V
- Wide operation temperature range:  $T_a = -40^\circ\text{C}$  to  $+85^\circ\text{C}$
- Low current consumption
 

During operation:	2.0 $\mu\text{A}$ typ., 4.0 $\mu\text{A}$ max. ( $T_a = +25^\circ\text{C}$ )
During power-down:	50 nA max. ( $T_a = +25^\circ\text{C}$ )
- Lead-free (Sn 100%), halogen-free

\*1. Overcharge release voltage = Overcharge detection voltage – Overcharge hysteresis voltage  
(Overcharge hysteresis voltage can be selected from a range of 0 V to 0.4 V in 50 mV step.)

\*2. Overdischarge release voltage = Overdischarge detection voltage + Overdischarge hysteresis voltage  
(Overdischarge hysteresis voltage can be selected from a range of 0 V to 0.7 V in 100 mV step.)

## ■ Applications

- Lithium-ion rechargeable battery pack
- Lithium polymer rechargeable battery pack

## ■ Package

- SNT-6A

■ **Block Diagram**



**Remark** All the diodes shown in the figure are parasitic diodes.

**Figure 1**

■ **Product Name Structure**

**1. Product name**



\*1. Refer to the tape drawing.

\*2. Refer to "3. Product name list".

**2. Package**

**Table 1 Package Drawing Codes**

Package Name	Dimension	Tape	Reel	Land
SNT-6A	PG006-A-P-SD	PG006-A-C-SD	PG006-A-R-SD	PG006-A-L-SD

**3. Product name list**

**3.1 SNT-6A**

**Table 2 (1 / 2)**

Product Name	Overcharge Detection Voltage [V <sub>CU</sub> ]	Overcharge Release Voltage [V <sub>CL</sub> ]	Overdischarge Detection Voltage [V <sub>DL</sub> ]	Overdischarge Release Voltage [V <sub>DU</sub> ]	Delay Time Combination* <sup>1</sup>	Function Combination* <sup>2</sup>
S-8250BAB-I6T1U	4.425 V	4.225 V	2.500 V	2.900 V	(1)	(2)
S-8250BAC-I6T1U	4.415 V	4.215 V	2.500 V	2.900 V	(1)	(2)
S-8250BAF-I6T1U	4.425 V	4.225 V	2.300 V	2.500 V	(1)	(1)
S-8250BAK-I6T1U	4.425 V	4.225 V	2.300 V	2.500 V	(1)	(1)
S-8250BAL-I6T1U	4.425 V	4.225 V	2.500 V	2.800 V	(2)	(1)
S-8250BAM-I6T1U	4.475 V	4.275 V	2.500 V	2.900 V	(3)	(2)
S-8250BAN-I6T1U	4.470 V	4.220 V	2.300 V	2.300 V	(4)	(3)
S-8250BAS-I6T1U	4.280 V	4.280 V	2.800 V	2.800 V	(5)	(4)
S-8250BAV-I6T1U	4.330 V	4.130 V	2.000 V	2.000 V	(1)	(2)

**Table 2 (2 / 2)**

Product Name	Discharge Overcurrent Detection Voltage [V <sub>DIOV</sub> ]			Load Short-circuiting Detection Voltage [V <sub>SHORT</sub> ]	Charge Overcurrent Detection Voltage [V <sub>CIOV</sub> ]
	V <sub>DD</sub> = 3.0 V	V <sub>DD</sub> = 3.4 V	V <sub>DD</sub> = 4.0 V		
S-8250BAB-I6T1U	0.134 V	0.125 V	0.115 V	0.300 V	-0.100 V
S-8250BAC-I6T1U	0.060 V	0.056 V	0.050 V	0.700 V	-0.050 V
S-8250BAF-I6T1U	0.072 V	0.069 V	0.066 V	0.225 V	-0.040 V
S-8250BAK-I6T1U	0.104 V	0.097 V	0.089 V	0.225 V	-0.055 V
S-8250BAL-I6T1U	0.061 V	0.060 V	0.057 V	0.250 V	-0.055 V
S-8250BAM-I6T1U	0.071 V	0.068 V	0.063 V	0.200 V	-0.050 V
S-8250BAN-I6T1U	0.113 V	0.108 V	0.100 V	0.500 V	-0.075 V
S-8250BAS-I6T1U	0.054 V	0.052 V	0.050 V	0.500 V	-0.100 V
S-8250BAV-I6T1U	0.110 V	0.100 V	0.091 V	0.300 V	-0.050 V

\*1. Refer to **Table 3** about the details of the delay time combinations.

\*2. Refer to **Table 5** about the details of the function combinations.

**Remark** Please contact our sales office for the products with detection voltage value other than those specified above.

**Table 3**

Delay Time Combination	Overcharge Detection Delay Time [t <sub>CU</sub> ]	Overdischarge Detection Delay Time [t <sub>DL</sub> ]	Discharge Overcurrent Detection Delay Time [t <sub>DIOV</sub> ]	Load Short-circuiting Detection Delay Time [t <sub>SHORT</sub> ]	Charge Overcurrent Detection Delay Time [t <sub>CIOV</sub> ]
(1)	1.0 s	32 ms	8 ms	280 μs	8 ms
(2)	1.0 s	64 ms	8 ms	280 μs	8 ms
(3)	1.0 s	64 ms	16 ms	280 μs	8 ms
(4)	1.0 s	32 ms	16 ms	280 μs	16 ms
(5)	1.0 s	64 ms	16 ms	280 μs	16 ms

**Remark** The delay times can be changed within the range listed in **Table 4**. For details, please contact our sales office.

**Table 4**

Delay Time	Symbol	Selection Range			Remark
Overcharge detection delay time	t <sub>CU</sub>	256 ms	512 ms	1.0 s <sup>*1</sup>	Select a value from the left.
Overdischarge detection delay time	t <sub>DL</sub>	32 ms	64 ms	128 ms <sup>*1</sup>	Select a value from the left.
Discharge overcurrent detection delay time	t <sub>DIOV</sub>	8 ms	16 ms <sup>*1</sup>	32 ms	Select a value from the left.
Load short-circuiting detection delay time	t <sub>SHORT</sub>	280 μs <sup>*1</sup>	530 μs	–	Select a value from the left.
Charge overcurrent detection delay time	t <sub>CIOV</sub>	8 ms	16 ms <sup>*1</sup>	32 ms	Select a value from the left.

\*1. This value is the delay time of the standard products.

**Table 5**

Function Combination	0 V Battery Charge Function <sup>*1</sup>	Power-down Function <sup>*2</sup>	Release Condition of Discharge Overcurrent Status <sup>*3</sup>
(1)	Available	Unavailable	Load disconnection
(2)	Unavailable	Unavailable	Load disconnection
(3)	Unavailable	Available	Load disconnection
(4)	Available	Available	Load disconnection

\*1. 0 V battery charge function "available" / "unavailable" is selectable.

\*2. Power-down function "available" / "unavailable" is selectable.

\*3. Release condition of discharge overcurrent status "load disconnection" / "charger connection" is selectable.

**Remark** Please contact our sales office for the products with function combinations other than those specified above.

■ **Pin Configuration**

1. **SNT-6A**



**Figure 2**

**Table 6**

Pin No.	Symbol	Description
1	NC <sup>*1</sup>	No connection
2	CO	Connection pin of charge control FET gate (CMOS output)
3	DO	Connection pin of discharge control FET gate (CMOS output)
4	VSS	Input pin for negative power supply
5	VDD	Input pin for positive power supply
6	VM	Voltage detection pin between VM pin and VSS pin (Overcurrent / charger detection pin)

\*1. NC pin is electrically open.  
 NC pin can be connected to VDD pin or VSS pin.

### ■ Absolute Maximum Ratings

Table 7

(Ta = +25°C unless otherwise specified)

Item	Symbol	Applied pin	Absolute Maximum Rating	Unit
Input voltage between VDD pin and VSS pin	$V_{DS}$	VDD	$V_{SS} - 0.3$ to $V_{SS} + 12$	V
VM pin input voltage	$V_{VM}$	VM	$V_{DD} - 28$ to $V_{DD} + 0.3$	V
DO pin output voltage	$V_{DO}$	DO	$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
CO pin output voltage	$V_{CO}$	CO	$V_{VM} - 0.3$ to $V_{DD} + 0.3$	V
Power dissipation	$P_D$	–	400*1	mW
Operation ambient temperature	$T_{opr}$	–	–40 to +85	°C
Storage temperature	$T_{stg}$	–	–55 to +125	°C

\*1. When mounted on board  
[Mounted board]

- (1) Board size: 114.3 mm × 76.2 mm × t1.6 mm
- (2) Board name: JEDEC STANDARD51-7

**Caution** The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.



Figure 3 Power Dissipation of Package (When Mounted on Board)

■ **Electrical Characteristics**

1. Ta = +25°C

**Table 8**

(Ta = +25°C unless otherwise specified)

Item	Symbol	Condition	Min.	Typ.	Max.	Unit	Test Circuit
<b>Detection Voltage</b>							
Overcharge detection voltage	V <sub>CU</sub>	–	V <sub>CU</sub> – 0.020	V <sub>CU</sub>	V <sub>CU</sub> + 0.020	V	1
		Ta = –10°C to +60°C*1	V <sub>CU</sub> – 0.025	V <sub>CU</sub>	V <sub>CU</sub> + 0.025	V	1
Overcharge release voltage	V <sub>CL</sub>	V <sub>CL</sub> ≠ V <sub>CU</sub>	V <sub>CL</sub> – 0.030	V <sub>CL</sub>	V <sub>CL</sub> + 0.030	V	1
		V <sub>CL</sub> = V <sub>CU</sub>	V <sub>CL</sub> – 0.025	V <sub>CL</sub>	V <sub>CL</sub> + 0.020	V	1
Overdischarge detection voltage	V <sub>DL</sub>	–	V <sub>DL</sub> – 0.050	V <sub>DL</sub>	V <sub>DL</sub> + 0.050	V	2
Overdischarge release voltage	V <sub>DU</sub>	V <sub>DL</sub> ≠ V <sub>DU</sub>	V <sub>DU</sub> – 0.100	V <sub>DU</sub>	V <sub>DU</sub> + 0.100	V	2
		V <sub>DL</sub> = V <sub>DU</sub>	V <sub>DU</sub> – 0.050	V <sub>DU</sub>	V <sub>DU</sub> + 0.050	V	2
Discharge overcurrent detection voltage	V <sub>DIOV</sub>	V <sub>DD</sub> = 3.0 V	V <sub>DIOV</sub> – 0.010	V <sub>DIOV</sub>	V <sub>DIOV</sub> + 0.010	V	2
		V <sub>DD</sub> = 3.4 V	V <sub>DIOV</sub> – 0.010	V <sub>DIOV</sub>	V <sub>DIOV</sub> + 0.010	V	2
		V <sub>DD</sub> = 4.0 V	V <sub>DIOV</sub> – 0.010	V <sub>DIOV</sub>	V <sub>DIOV</sub> + 0.010	V	2
Load short-circuiting detection voltage	V <sub>SHORT</sub>	–	V <sub>SHORT</sub> – 0.050	V <sub>SHORT</sub>	V <sub>SHORT</sub> + 0.050	V	2
Discharge overcurrent release voltage	V <sub>RIOV</sub>	–	V <sub>DD</sub> – 1.2	V <sub>DD</sub> – 0.8	V <sub>DD</sub> – 0.5	V	2
Charge overcurrent detection voltage	V <sub>CIOV</sub>	–	V <sub>CIOV</sub> – 0.015	V <sub>CIOV</sub>	V <sub>CIOV</sub> + 0.015	V	2
<b>0 V Battery Charge Function</b>							
0 V battery charge starting charger voltage	V <sub>0CHA</sub>	0 V battery charge function "available"	0.00	0.70	1.00	V	2
0 V battery charge inhibition battery voltage	V <sub>0INH</sub>	0 V battery charge function "unavailable"	0.90	1.25	1.60	V	2
<b>Internal Resistance</b>							
Resistance between VM pin and VDD pin	R <sub>VMD</sub>	–	500	1000	2000	kΩ	3
Resistance between VM pin and VSS pin	R <sub>VMS</sub>	–	10	20	40	kΩ	3
<b>Input Voltage</b>							
Operation voltage between VDD pin and VSS pin	V <sub>DSOP1</sub>	–	1.5	–	6.5	V	–
Operation voltage between VDD pin and VM pin	V <sub>DSOP2</sub>	–	1.5	–	28	V	–
<b>Input Current</b>							
Current consumption during operation	I <sub>OPE</sub>	–	–	2.0	4.0	μA	3
Current consumption during power-down	I <sub>PDN</sub>	–	–	–	50	nA	3
Current consumption during overdischarge	I <sub>OPED</sub>	–	–	–	1.0	μA	3
<b>Output Resistance</b>							
CO pin resistance "H"	R <sub>COH</sub>	–	5	10	20	kΩ	4
CO pin resistance "L"	R <sub>COL</sub>	–	5	10	20	kΩ	4
DO pin resistance "H"	R <sub>DOH</sub>	–	5	10	20	kΩ	4
DO pin resistance "L"	R <sub>DOH</sub>	–	5	10	20	kΩ	4
<b>Delay Time</b>							
Overcharge detection delay time	t <sub>CU</sub>	–	t <sub>CU</sub> × 0.8	t <sub>CU</sub>	t <sub>CU</sub> × 1.2	–	5
Overdischarge detection delay time	t <sub>DL</sub>	–	t <sub>DL</sub> × 0.8	t <sub>DL</sub>	t <sub>DL</sub> × 1.2	–	5
Discharge overcurrent detection delay time	t <sub>DIOV</sub>	–	t <sub>DIOV</sub> × 0.8	t <sub>DIOV</sub>	t <sub>DIOV</sub> × 1.2	–	5
Load short-circuiting detection delay time	t <sub>SHORT</sub>	–	t <sub>SHORT</sub> × 0.7	t <sub>SHORT</sub>	t <sub>SHORT</sub> × 1.3	–	5
Charge overcurrent detection delay time	t <sub>CIOV</sub>	–	t <sub>CIOV</sub> × 0.8	t <sub>CIOV</sub>	t <sub>CIOV</sub> × 1.2	–	5

\*1. Since products are not screened at high and low temperature, the specification for this temperature range is guaranteed by design, not tested in production.



# BATTERY PROTECTION IC FOR 1-CELL PACK S-8250B Series

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2. Ta = -40°C to +85°C\*1

Table 9

(Ta = -40°C to +85°C\*1 unless otherwise specified)

Item	Symbol	Condition	Min.	Typ.	Max.	Unit	Test Circuit
<b>Detection Voltage</b>							
Overcharge detection voltage	V <sub>CU</sub>	–	V <sub>CU</sub> – 0.045	V <sub>CU</sub>	V <sub>CU</sub> + 0.030	V	1
Overcharge release voltage	V <sub>CL</sub>	V <sub>CL</sub> ≠ V <sub>CU</sub>	V <sub>CL</sub> – 0.070	V <sub>CL</sub>	V <sub>CL</sub> + 0.040	V	1
		V <sub>CL</sub> = V <sub>CU</sub>	V <sub>CL</sub> – 0.050	V <sub>CL</sub>	V <sub>CL</sub> + 0.030	V	1
Overdischarge detection voltage	V <sub>DL</sub>	–	V <sub>DL</sub> – 0.090	V <sub>DL</sub>	V <sub>DL</sub> + 0.060	V	2
Overdischarge release voltage	V <sub>DU</sub>	V <sub>DL</sub> ≠ V <sub>DU</sub>	V <sub>DU</sub> – 0.140	V <sub>DU</sub>	V <sub>DU</sub> + 0.110	V	2
		V <sub>DL</sub> = V <sub>DU</sub>	V <sub>DU</sub> – 0.090	V <sub>DU</sub>	V <sub>DU</sub> + 0.060	V	2
Discharge overcurrent detection voltage*2	V <sub>DIOV</sub>	V <sub>DD</sub> = 3.0 V	–	V <sub>DIOV</sub>	–	V	2
		V <sub>DD</sub> = 3.4 V	–	V <sub>DIOV</sub>	–	V	2
		V <sub>DD</sub> = 4.0 V	–	V <sub>DIOV</sub>	–	V	2
Load short-circuiting detection voltage	V <sub>SHORT</sub>	–	V <sub>SHORT</sub> – 0.050	V <sub>SHORT</sub>	V <sub>SHORT</sub> + 0.050	V	2
Discharge overcurrent release voltage	V <sub>RIOV</sub>	–	V <sub>DD</sub> – 1.4	V <sub>DD</sub> – 0.8	V <sub>DD</sub> – 0.3	V	2
Charge overcurrent detection voltage	V <sub>CIOV</sub>	–	V <sub>CIOV</sub> – 0.015	V <sub>CIOV</sub>	V <sub>CIOV</sub> + 0.015	V	2
<b>0 V Battery Charge Function</b>							
0 V battery charge starting charger voltage	V <sub>0CHA</sub>	0 V battery charge function "available"	0.00	0.70	1.50	V	2
0 V battery charge inhibition battery voltage	V <sub>0INH</sub>	0 V battery charge function "unavailable"	0.70	1.25	1.80	V	2
<b>Internal Resistance</b>							
Resistance between VM pin and VDD pin	R <sub>VMD</sub>	–	250	1000	3000	kΩ	3
Resistance between VM pin and VSS pin	R <sub>VMS</sub>	–	7.2	20	44	kΩ	3
<b>Input Voltage</b>							
Operation voltage between VDD pin and VSS pin	V <sub>DSOP1</sub>	–	1.5	–	6.5	V	–
Operation voltage between VDD pin and VM pin	V <sub>DSOP2</sub>	–	1.5	–	28	V	–
<b>Input Current</b>							
Current consumption during operation	I <sub>OPE</sub>	–	–	2.0	4.5	μA	3
Current consumption during power-down	I <sub>PDN</sub>	–	–	–	100	nA	3
Current consumption during overdischarge	I <sub>OPEd</sub>	–	–	–	2.0	μA	3
<b>Output Resistance</b>							
CO pin resistance "H"	R <sub>COH</sub>	–	2.5	10	30	kΩ	4
CO pin resistance "L"	R <sub>COL</sub>	–	2.5	10	30	kΩ	4
DO pin resistance "H"	R <sub>DOH</sub>	–	2.5	10	30	kΩ	4
DO pin resistance "L"	R <sub>DOL</sub>	–	2.5	10	30	kΩ	4
<b>Delay Time</b>							
Overcharge detection delay time	t <sub>CU</sub>	–	t <sub>CU</sub> × 0.6	t <sub>CU</sub>	t <sub>CU</sub> × 1.6	–	5
Overdischarge detection delay time	t <sub>DL</sub>	–	t <sub>DL</sub> × 0.6	t <sub>DL</sub>	t <sub>DL</sub> × 1.6	–	5
Discharge overcurrent detection delay time	t <sub>DIOV</sub>	–	t <sub>DIOV</sub> × 0.6	t <sub>DIOV</sub>	t <sub>DIOV</sub> × 1.6	–	5
Load short-circuiting detection delay time	t <sub>SHORT</sub>	–	t <sub>SHORT</sub> × 0.5	t <sub>SHORT</sub>	t <sub>SHORT</sub> × 1.7	–	5
Charge overcurrent detection delay time	t <sub>CIOV</sub>	–	t <sub>CIOV</sub> × 0.6	t <sub>CIOV</sub>	t <sub>CIOV</sub> × 1.6	–	5

\*1. Since products are not screened at high and low temperature, the specification for this temperature range is guaranteed by design, not tested in production.

\*2. The temperature characteristics of V<sub>DIOV</sub> is determined depending on the setting of V<sub>DIOV</sub>, and accords closely with the temperature characteristics of ON resistance of the charge-discharge control FET.

Refer to "2. 5 V<sub>DIOV</sub> vs. Ta" in "■ Characteristics (Typical Data)" for details.

## ■ Test Circuits

**Caution** Unless otherwise specified, the output voltage levels "H" and "L" at CO pin ( $V_{CO}$ ) and DO pin ( $V_{DO}$ ) are judged by the threshold voltage (1.0 V) of the N-channel FET. Judge the CO pin level with respect to  $V_{VM}$  and the DO pin level with respect to  $V_{SS}$ .

### 1. Overcharge detection voltage, overcharge release voltage (Test circuit 1)

Overcharge detection voltage ( $V_{CU}$ ) is defined as the voltage  $V_1$  at which  $V_{CO}$  goes from "H" to "L" when the voltage  $V_1$  is gradually increased from the starting conditions of  $V_1 = 3.4$  V. Overcharge release voltage ( $V_{CL}$ ) is defined as the voltage  $V_1$  at which  $V_{CO}$  goes from "L" to "H" when the voltage  $V_1$  is then gradually decreased. Overcharge hysteresis voltage ( $V_{HC}$ ) is defined as the difference between  $V_{CU}$  and  $V_{CL}$ .

### 2. Overdischarge detection voltage, overdischarge release voltage (Test circuit 2)

Overdischarge detection voltage ( $V_{DL}$ ) is defined as the voltage  $V_1$  at which  $V_{DO}$  goes from "H" to "L" when the voltage  $V_1$  is gradually decreased from the starting conditions of  $V_1 = 3.4$  V,  $V_2 = 0$  V. Overdischarge release voltage ( $V_{DU}$ ) is defined as the voltage  $V_1$  at which  $V_{DO}$  goes from "L" to "H" when the voltage  $V_1$  is then gradually increased from the starting condition of  $V_2 = 0.02$  V. Overdischarge hysteresis voltage ( $V_{HD}$ ) is defined as the difference between  $V_{DU}$  and  $V_{DL}$ .

### 3. Discharge overcurrent detection voltage (Test circuit 2)

Discharge overcurrent detection voltage ( $V_{DIOV}$ ) is defined as the voltage  $V_2$  whose delay time for changing  $V_{DO}$  from "H" to "L" is discharge overcurrent detection delay time ( $t_{DIOV}$ ) when the voltage  $V_2$  is increased from the starting conditions of  $V_1 = 3.4$  V,  $V_2 = 0$  V.

### 4. Discharge overcurrent release voltage (Release condition of discharge overcurrent status "load disconnection") (Test circuit 2)

Set  $V_1 = 3.4$  V,  $V_2 = 0$  V. Discharge overcurrent release voltage ( $V_{RIOV}$ ) is defined as the voltage  $V_2$  at which  $V_{DO}$  goes from "L" to "H" when the voltage  $V_2$  is then gradually decreased from the starting condition of  $V_2 = 3.4$  V.

### 5. Load short-circuiting detection voltage (Test circuit 2)

Load short-circuiting detection voltage ( $V_{SHORT}$ ) is defined as the voltage  $V_2$  whose delay time for changing  $V_{DO}$  from "H" to "L" is load short-circuiting detection delay time ( $t_{SHORT}$ ) when the voltage  $V_2$  is increased from the starting conditions of  $V_1 = 3.4$  V,  $V_2 = 0$  V.

### 6. Charge overcurrent detection voltage (Test circuit 2)

Charge overcurrent detection voltage ( $V_{CIOV}$ ) is defined as the voltage  $V_2$  whose delay time for changing  $V_{CO}$  from "H" to "L" is charge overcurrent detection delay time ( $t_{CIOV}$ ) when the voltage  $V_2$  is decreased from the starting conditions of  $V_1 = 3.4$  V,  $V_2 = 0$  V.

### 7. Current consumption during operation (Test circuit 3)

The current consumption during operation ( $I_{OPE}$ ) is the current that flows through the VDD pin ( $I_{DD}$ ) under the set conditions of  $V_1 = 3.4$  V,  $V_2 = 0$  V.

**8. Current consumption during power-down, current consumption during overdischarge (Test circuit 3)**

**8.1 With power-down function**

The current consumption during power-down ( $I_{PDN}$ ) is  $I_{DD}$  under the set condition of  $V1 = V2 = 1.5$  V.

**8.2 Without power-down function**

The current consumption during overdischarge ( $I_{OPED}$ ) is  $I_{DD}$  under the set condition of  $V1 = V2 = 1.5$  V.

**9. Resistance between VM pin and VDD pin (Test circuit 3)**

Resistance between VM pin and VDD pin is  $R_{VMD}$  under the set conditions of  $V1 = 1.8$  V,  $V2 = 0$  V.

**10. Resistance between VM pin and VSS pin (Release condition of discharge overcurrent status "load disconnection") (Test circuit 3)**

Resistance between VM pin and VSS pin is  $R_{VMS}$  under the set conditions of  $V1 = 3.4$  V,  $V2 = 1.0$  V.

**11. CO pin resistance "H" (Test circuit 4)**

The CO pin resistance "H" ( $R_{COH}$ ) is the resistance between VDD pin and CO pin under the set conditions of  $V1 = 3.4$  V,  $V2 = 0$  V,  $V3 = 3.0$  V.

**12. CO pin resistance "L" (Test circuit 4)**

The CO pin resistance "L" ( $R_{COL}$ ) is the resistance between VM pin and CO pin under the set conditions of  $V1 = 4.6$  V,  $V2 = 0$  V,  $V3 = 0.4$  V.

**13. DO pin resistance "H" (Test circuit 4)**

The DO pin resistance "H" ( $R_{DOH}$ ) is the resistance between VDD pin and DO pin under the set conditions of  $V1 = 3.4$  V,  $V2 = 0$  V,  $V4 = 3.0$  V.

**14. DO pin resistance "L" (Test circuit 4)**

The DO pin resistance "L" ( $R_{DOL}$ ) is the resistance between VSS pin and DO pin under the set conditions of  $V1 = 1.8$  V,  $V2 = 0$  V,  $V4 = 0.4$  V.

**15. Overcharge detection delay time (Test circuit 5)**

The overcharge detection delay time ( $t_{CU}$ ) is the time needed for  $V_{CO}$  to go to "L" after the voltage  $V1$  increases and exceeds  $V_{CU}$  under the set conditions of  $V1 = 3.4$  V,  $V2 = 0$  V.

**16. Overdischarge detection delay time (Test circuit 5)**

The overdischarge detection delay time ( $t_{DL}$ ) is the time needed for  $V_{DO}$  to go to "L" after the voltage  $V1$  decreases and falls below  $V_{DL}$  under the set conditions of  $V1 = 3.4$  V,  $V2 = 0$  V.

**17. Discharge overcurrent detection delay time**  
**(Test circuit 5)**

$t_{DIOV}$  is the time needed for  $V_{DO}$  to go to "L" after the voltage  $V_2$  increases and exceeds  $V_{DIOV}$  under the set conditions of  $V_1 = 3.4\text{ V}$ ,  $V_2 = 0\text{ V}$ .

**18. Load short-circuiting detection delay time**  
**(Test circuit 5)**

$t_{SHORT}$  is the time needed for  $V_{DO}$  to go to "L" after the voltage  $V_2$  increases and exceeds  $V_{SHORT}$  under the set conditions of  $V_1 = 3.4\text{ V}$ ,  $V_2 = 0\text{ V}$ .

**19. Charge overcurrent detection delay time**  
**(Test circuit 5)**

$t_{CIOV}$  is the time needed for  $V_{CO}$  to go to "L" after the voltage  $V_2$  decreases and falls below  $V_{CIOV}$  under the set conditions of  $V_1 = 3.4\text{ V}$ ,  $V_2 = 0\text{ V}$ .

**20. 0 V battery charge starting charger voltage (0 V battery charge function "available")**  
**(Test circuit 2)**

The 0 V battery charge starting charger voltage ( $V_{0CHA}$ ) is defined as absolute value of the voltage  $V_2$  at which  $V_{CO}$  goes to "H" ( $V_{CO} = V_{DD}$ ) when the voltage  $V_2$  is gradually decreased under the set condition of  $V_1 = V_2 = 0\text{ V}$ .

**21. 0 V battery charge inhibition battery voltage (0 V battery charge function "unavailable")**  
**(Test circuit 2)**

The 0 V battery charge inhibition battery voltage ( $V_{0INH}$ ) is defined as the voltage  $V_1$  at which  $V_{CO}$  goes to "H" ( $V_{CO} = V_{DD}$ ) when the voltage  $V_1$  is gradually increased under the set conditions of  $V_1 = 0\text{ V}$ ,  $V_2 = -2.0\text{ V}$ .



**Figure 4 Test Circuit 1**



**Figure 5 Test Circuit 2**



**Figure 6 Test Circuit 3**



**Figure 7 Test Circuit 4**



**Figure 8 Test Circuit 5**

## ■ Operation

**Remark** Refer to "■ Battery Protection IC Connection Example".

### 1. Normal status

The S-8250B Series monitors the voltage of the battery connected between the VDD pin and VSS pin and the voltage between the VM pin and VSS pin to control charging and discharging. When the battery voltage is in the range from the overdischarge detection voltage ( $V_{DL}$ ) to the overcharge detection voltage ( $V_{CU}$ ), and the VM pin voltage is in the range from the charge overcurrent detection voltage ( $V_{CIOV}$ ) to the discharge overcurrent detection voltage ( $V_{DIOV}$ ), the S-8250B Series turns both the charge and discharge control FETs on. This condition is called the normal status, and in this condition charging and discharging can be carried out freely.

The resistance between the VM pin and VDD pin ( $R_{VMD}$ ) and the resistance between the VM pin and VSS pin ( $R_{VMS}$ ) are not connected in the normal status.

**Caution** When the battery is connected for the first time, the S-8250B Series may not be in the normal status. In this case, short the VM pin and VSS pin, or set the VM pin voltage at the level of  $V_{CIOV}$  or more and at the level of  $V_{DIOV}$  or less by connecting the charger. The S-8250B Series then becomes the normal status.

### 2. Overcharge status

#### 2.1 $V_{CL} \neq V_{CU}$ (Product in which overcharge release voltage differs from overcharge detection voltage)

When the battery voltage becomes higher than  $V_{CU}$  during charging in the normal status and detection continues for the overcharge detection delay time ( $t_{CU}$ ) or longer, the S-8250B Series turns the charge control FET off to stop charging. This condition is called the overcharge status.

The overcharge status is released in the following two cases.

- (1) In the case that the VM pin voltage is lower than  $V_{DIOV}$ , the S-8250B Series releases the overcharge status when the battery voltage falls below overcharge release voltage ( $V_{CL}$ ).
- (2) In the case that the VM pin voltage is equal to or higher than  $V_{DIOV}$ , the S-8250B Series releases the overcharge status when the battery voltage falls below  $V_{CU}$ .

When the discharge is started by connecting a load after the overcharge detection, the VM pin voltage rises by the  $V_f$  voltage of the parasitic diode than the VSS pin voltage, because the discharge current flows through the parasitic diode in the charge control FET. If this VM pin voltage is equal to or higher than  $V_{DIOV}$ , the S-8250B Series releases the overcharge status when the battery voltage is equal to or lower than  $V_{CU}$ .

**Caution** If the battery is charged to a voltage higher than  $V_{CU}$  and the battery voltage does not fall below  $V_{CU}$  even when a heavy load is connected, discharge overcurrent detection and load short-circuiting detection do not function until the battery voltage falls below  $V_{CU}$ . Since an actual battery has an internal impedance of tens of  $m\Omega$ , the battery voltage drops immediately after a heavy load that causes overcurrent is connected, and discharge overcurrent detection and load short-circuiting detection function.

#### 2.2 $V_{CL} = V_{CU}$ (Product in which overcharge release voltage is the same as overcharge detection voltage)

When the battery voltage becomes higher than  $V_{CU}$  during charging in the normal status and detection continues for the overcharge detection delay time ( $t_{CU}$ ) or longer, the S-8250B Series turns the charge control FET off to stop charging. This condition is called the overcharge status.

In the case that the VM pin voltage is higher than 0 V typ., the S-8250B Series releases the overcharge status when the battery voltage falls below  $V_{CU}$ .

**Caution** 1. If the battery is charged to a voltage higher than  $V_{CU}$  and the battery voltage does not fall below  $V_{CU}$  even when a heavy load is connected, discharge overcurrent detection and load short-circuiting detection do not function until the battery voltage falls below  $V_{CU}$ . Since an actual battery has an internal impedance of tens of  $m\Omega$ , the battery voltage drops immediately after a heavy load that causes overcurrent is connected, and discharge overcurrent detection and load short-circuiting detection function.

2. When a charger is connected after overcharge detection, the overcharge status is not released even if the battery voltage is below  $V_{CL}$ . The overcharge status is released when the VM pin voltage goes over 0 V typ. by removing the charger.

### 3. Overdischarge status

When the battery voltage falls below  $V_{DL}$  during discharging in the normal status and the condition continues for the overdischarge detection delay time ( $t_{DL}$ ) or longer, the S-8250B Series turns the discharge control FET off to stop discharging. This condition is called the overdischarge status.

Under the overdischarge status, VDD pin and VM pin are shorted by  $R_{VMD}$  in the S-8250B Series. The VM pin voltage is pulled up by  $R_{VMD}$ .

$R_{VMS}$  is not connected in the overdischarge status.

#### 3.1 With power-down function

Under the overdischarge status, when voltage difference between VDD pin and VM pin is 0.8 V typ. or lower, the power-down function works and the current consumption is reduced to the current consumption during power-down ( $I_{PDN}$ ). By connecting a battery charger, the power-down function is released when the VM pin voltage is 0.7 V typ. or lower.

- When a battery is not connected to a charger and the VM pin voltage  $\geq 0.7$  V typ., the S-8250B Series maintains the overdischarge status even when the battery voltage reaches  $V_{DU}$  or higher.
- When a battery is connected to a charger and 0.7 V typ. > the VM pin voltage > 0 V typ., the battery voltage reaches  $V_{DU}$  or higher and the S-8250B Series releases the overdischarge status.
- When a battery is connected to a charger and 0 V typ.  $\geq$  the VM pin voltage, the battery voltage reaches  $V_{DL}$  or higher and the S-8250B Series releases the overdischarge status.

#### 3.2 Without power-down function

Under the overdischarge status, the power-down function does not work even when voltage difference between VDD pin and VM pin is 0.8 V typ. or lower.

- When a battery is not connected to a charger and the VM pin voltage  $\geq 0.7$  V typ., the battery voltage reaches  $V_{DU}$  or higher and the S-8250B Series releases the overdischarge status.
- When a battery is connected to a charger and 0.7 V typ. > the VM pin voltage > 0 V typ., the battery voltage reaches  $V_{DU}$  or higher and the S-8250B Series releases the overdischarge status.
- When a battery is connected to a charger and 0 V typ.  $\geq$  the VM pin voltage, the battery voltage reaches  $V_{DL}$  or higher and the S-8250B Series releases the overdischarge status.

### 4. Discharge overcurrent status (Discharge overcurrent, load short-circuiting)

When a battery in the normal status is in the status where the VM pin voltage is equal to or higher than  $V_{DIOV}$  because the discharge current is equal to or higher than the specified value and the status lasts for the discharge overcurrent detection delay time ( $t_{DIOV}$ ) or longer, the discharge control FET is turned off and discharging is stopped. This status is called the discharge overcurrent status.

#### 4.1 Release condition of discharge overcurrent status "load disconnection"

In the discharge overcurrent status, the VM pin and VSS pin are shorted by  $R_{VMS}$  in the S-8250B Series. However, the VM pin voltage is the VDD pin voltage due to the load as long as the load is connected. When the load is disconnected, the VM pin voltage returns to the VSS pin voltage. If the VM pin voltage returns to the discharge overcurrent release voltage ( $V_{RIOV}$ ) or lower, the S-8250B Series releases the discharge overcurrent status.

$R_{VMD}$  is not connected in the discharge overcurrent status.

#### 4.2 Release condition of discharge overcurrent status "charger connection"

In the discharge overcurrent status, the VM pin and VDD pin are shorted by  $R_{VMD}$  in the S-8250B Series.

If the VM pin voltage returns to  $V_{DIOV}$  or lower by connecting a charger, the S-8250B Series releases the discharge overcurrent status.

$R_{VMS}$  is not connected in the discharge overcurrent status.

### 5. Charge overcurrent status

When a battery in the normal status is in the status where the VM pin voltage is equal to or lower than  $V_{CIOV}$  because the charge current is equal to or higher than the specified value and the status lasts for the charge overcurrent detection delay time ( $t_{CIOV}$ ) or longer, the charge control FET is turned off and charging is stopped. This status is called the charge overcurrent status.

The S-8250B Series releases the charge overcurrent status when the VM pin voltage returns to 0 V typ. or higher by removing the charger.

The charge overcurrent detection does not function in the overdischarge status.

**6. 0 V battery charge function "available"**

This function is used to recharge a connected battery whose voltage is 0 V due to self-discharge. When the 0 V battery charge starting charger voltage ( $V_{0CHA}$ ) or a higher voltage is applied between the EB+ pin and EB- pin by connecting a charger, the charge control FET gate is fixed to the VDD pin voltage. When the voltage between the gate and source of the charge control FET becomes equal to or higher than the threshold voltage due to the charger voltage, the charge control FET is turned on to start charging. At this time, the discharge control FET is off and the charge current flows through the internal parasitic diode in the discharge control FET. When the battery voltage becomes equal to or higher than  $V_{DU}$ , the S-8250B Series enters the normal status.

- Caution**
- 1. Some battery providers do not recommend charging for a completely self-discharged battery. Please ask the battery provider to determine whether to enable or inhibit the 0 V battery charge function.**
  - 2. The 0 V battery charge function has higher priority than the charge overcurrent detection function. Consequently, a product in which use of the 0 V battery charge function is enabled charges a battery forcibly and the charge overcurrent cannot be detected when the battery voltage is lower than  $V_{DL}$ .**

**7. 0 V battery charge function "unavailable"**

This function inhibits recharging when a battery that is internally short-circuited (0 V battery) is connected. When the battery voltage is the 0 V battery charge inhibition battery voltage ( $V_{0INH}$ ) or lower, the charge control FET gate is fixed to the EB- pin voltage to inhibit charging. When the battery voltage is  $V_{0INH}$  or higher, charging can be performed.

- Caution** Some battery providers do not recommend charging for a completely self-discharged battery. Please ask the battery provider to determine whether to enable or inhibit the 0 V battery charge function.

**8. Delay circuit**

The detection delay times are determined by dividing a clock of approximately 4 kHz by the counter.

- Remark**  $t_{DIOV}$  and  $t_{SHORT}$  start when  $V_{DIOV}$  is detected. When  $V_{SHORT}$  is detected over  $t_{SHORT}$  after  $V_{DIOV}$ , the S-8250B Series turns the discharge control FET off within  $t_{SHORT}$  from the time of detecting  $V_{SHORT}$ .



Figure 9



■ Timing Chart

1. Overcharge detection, overdischarge detection



- \*1. (1): Normal status  
 (2): Overcharge status  
 (3): Overdischarge status

**Remark** The charger is assumed to charge with a constant current.

Figure 10

**2. Discharge overcurrent detection**

**2.1 Release condition of discharge overcurrent status "load disconnection"**



\*1. (1): Normal status  
 (2): Discharge overcurrent status

**Remark** The charger is assumed to charge with a constant current.

**Figure 11**

2. 2 Release condition of discharge overcurrent status "charger connection"



\*1. (1): Normal status  
(2): Discharge overcurrent status

**Remark** The charger is assumed to charge with a constant current.

Figure 12

**3. Charge overcurrent detection**



- \*1. (1): Normal status  
 (2): Charge overcurrent status  
 (3): Overdischarge status

**Remark** The charger is assumed to charge with a constant current.

**Figure 13**

■ **Battery Protection IC Connection Example**



Figure 14

**Table 10 Constants for External Components**

Symbol	Part	Purpose	Min.	Typ.	Max.	Remark
FET1	N-channel MOS FET	Discharge control	-	-	-	Threshold voltage $\leq$ Overdischarge detection voltage <sup>*1</sup> Gate to source withstand voltage $\geq$ Charger voltage <sup>*2</sup>
FET2	N-channel MOS FET	Charge control	-	-	-	Threshold voltage $\leq$ Overdischarge detection voltage <sup>*1</sup> Gate to source withstand voltage $\geq$ Charger voltage <sup>*2</sup>
R1	Resistor	ESD protection, For power fluctuation	150 $\Omega$	330 $\Omega$	510 $\Omega$	Resistance should be as small as possible to avoid worsening the overcharge detection accuracy due to current consumption. <sup>*3</sup>
C1	Capacitor	For power fluctuation	0.068 $\mu\text{F}$	0.1 $\mu\text{F}$	1.0 $\mu\text{F}$	Connect a capacitor of 0.068 $\mu\text{F}$ or higher between VDD pin and VSS pin. <sup>*4</sup>
R2	Resistor	Protection for reverse connection of a charger	1 k $\Omega$	2 k $\Omega$	4 k $\Omega$	Select as large a resistance as possible to prevent current when a charger is connected in reverse. <sup>*5</sup>

- \*1. If the threshold voltage of a FET is low, the FET may not cut the charge current. If a FET with a threshold voltage equal to or higher than the overdischarge detection voltage is used, discharging may be stopped before overdischarge is detected.
- \*2. If the withstand voltage between the gate and source is lower than the charger voltage, the FET may be destroyed.
- \*3. An accuracy of overcharge detection voltage is guaranteed by R1 = 330  $\Omega$ . Connecting resistors with other values worsen the accuracy. In case of connecting a larger resistor to R1, the voltage between the VDD pin and VSS pin may exceed the absolute maximum rating because the current flows to the S-8250B Series from the charger due to reverse connection of charger. Connect a resistor of 150  $\Omega$  or more to R1 for ESD protection.
- \*4. When connecting a resistor less than 150  $\Omega$  to R1 or a capacitor less than 0.068  $\mu\text{F}$  to C1, the S-8250B Series may malfunction when power dissipation is largely fluctuated.
- \*5. When a resistor more than 4 k $\Omega$  is connected to R2, the charge current may not be cut.

**Caution 1. The above constants may be changed without notice.**

2. It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constant do not guarantee proper operation. Perform thorough evaluation using the actual application to set the constant.

■ **Precautions**

- The application conditions for the input voltage, output voltage, and load current should not exceed the package power dissipation.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- ABLIC Inc. claims no responsibility for any and all disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

■ Characteristics (Typical Data)

1. Current consumption

1.1  $I_{OPE}$  vs.  $T_a$



1.2  $I_{OPE}$  vs.  $V_{DD}$



1.3  $I_{PDN}$  vs.  $T_a$



2. Detection voltage

2.1  $V_{CU}$  vs.  $T_a$



2.2  $V_{CL}$  vs.  $T_a$



2.3  $V_{DL}$  vs.  $T_a$



2.4  $V_{DU}$  vs.  $T_a$



**2.5  $V_{DIOV}$  vs.  $T_a$**

$V_{DD} = 3.4 \text{ V}$



**2.6  $V_{DIOV}$  vs.  $V_{DD}$**



$n = 1 \sim 3$

**2.7  $V_{SHORT}$  vs.  $T_a$**



**2.8  $V_{SHORT}$  vs.  $V_{DD}$**



**2.9  $V_{CIOV}$  vs.  $T_a$**



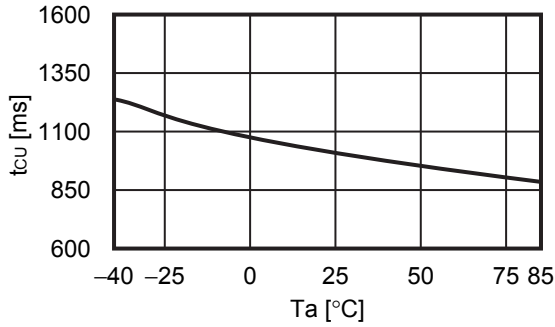
**2.10  $V_{CIOV}$  vs.  $V_{DD}$**



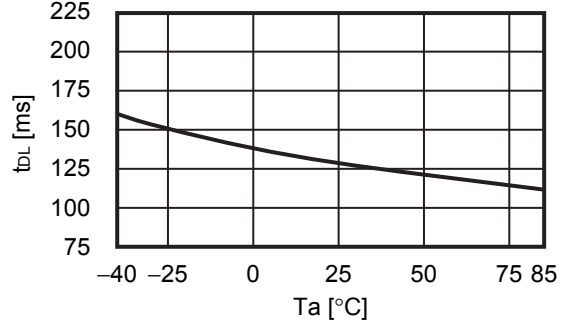


3. Delay time

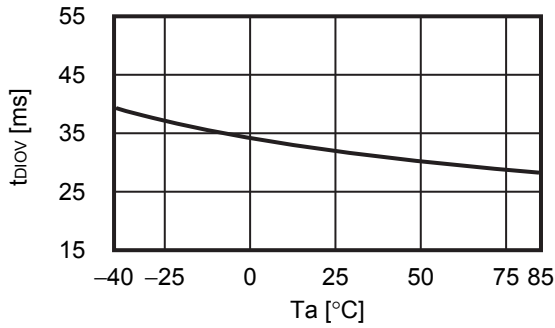
3.1  $t_{CU}$  vs.  $T_a$



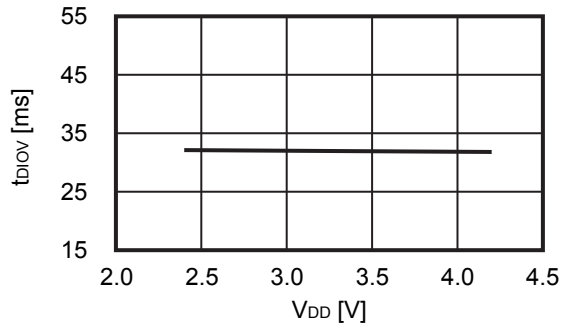
3.2  $t_{DL}$  vs.  $T_a$



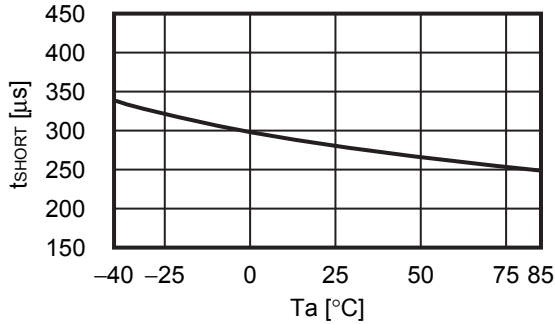
3.3  $t_{DIOV}$  vs.  $T_a$



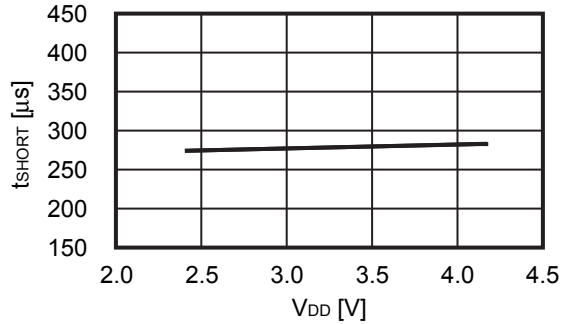
3.4  $t_{DIOV}$  vs.  $V_{DD}$



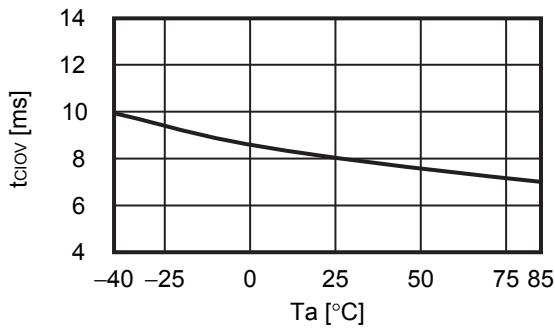
3.5  $t_{SHORT}$  vs.  $T_a$



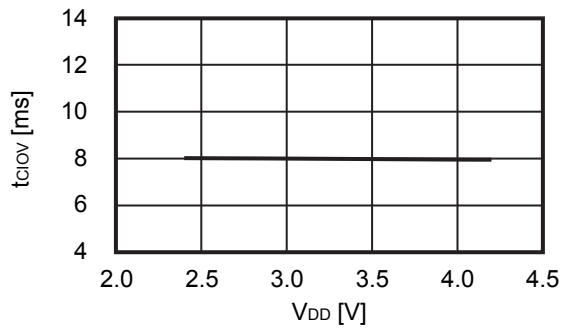
3.6  $t_{SHORT}$  vs.  $V_{DD}$



3.7  $t_{CIOV}$  vs.  $T_a$



3.8  $t_{CIOV}$  vs.  $V_{DD}$



**4. Output resistance**

**4.1  $R_{COH}$  vs.  $V_{CO}$**



**4.2  $R_{COL}$  vs.  $V_{CO}$**



**4.3  $R_{DOH}$  vs.  $V_{DO}$**



**4.4  $R_{DOL}$  vs.  $V_{DO}$**



■ **Marking Specification**

1. **SNT-6A**



(1) to (3): Product code (refer to **Product name vs. Product code**)

(4) to (6): Lot number

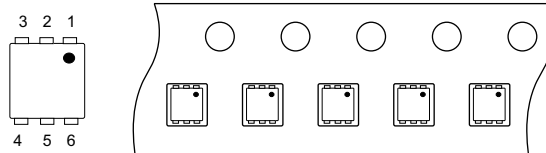
**Product name vs. Product code**

Product Name	Product Code		
	(1)	(2)	(3)
S-8250BAB-I6T1U	4	O	B
S-8250BAC-I6T1U	4	O	C
S-8250BAF-I6T1U	4	O	F
S-8250BAK-I6T1U	4	O	K
S-8250BAL-I6T1U	4	O	L
S-8250BAM-I6T1U	4	O	M
S-8250BAN-I6T1U	4	O	N
S-8250BAS-I6T1U	4	O	S
S-8250BAV-I6T1U	4	O	V



No. PG006-A-P-SD-2.1

TITLE	SNT-6A-A-PKG Dimensions
No.	PG006-A-P-SD-2.1
ANGLE	
UNIT	mm
<b>ABLIC Inc.</b>	



No. PG006-A-C-SD-2.0

TITLE	SNT-6A-A-Carrier Tape
No.	PG006-A-C-SD-2.0
ANGLE	
UNIT	mm
<b>ABLIC Inc.</b>	



Enlarged drawing in the central part



No. PG006-A-R-SD-1.0

TITLE	SNT-6A-A-Reel		
No.	PG006-A-R-SD-1.0		
ANGLE		QTY.	5,000
UNIT	mm		
<b>ABLIC Inc.</b>			



※1. ランドパターンの幅に注意してください (0.25 mm min. / 0.30 mm typ.).  
 ※2. パッケージ中央にランドパターンを広げないでください (1.30 mm ~ 1.40 mm)。

- 注意
1. パッケージのモールド樹脂下にシルク印刷やハンダ印刷などしないでください。
  2. パッケージ下の配線上のソルダーレジストなどの厚みをランドパターン表面から0.03 mm以下にしてください。
  3. マスク開口サイズと開口位置はランドパターンと合わせてください。
  4. 詳細は“SNTパッケージ活用の手引き”を参照してください。

※1. Pay attention to the land pattern width (0.25 mm min. / 0.30 mm typ.).  
 ※2. Do not widen the land pattern to the center of the package ( 1.30 mm ~ 1.40 mm ).

- Caution**
1. Do not do silkscreen printing and solder printing under the mold resin of the package.
  2. The thickness of the solder resist on the wire pattern under the package should be 0.03 mm or less from the land pattern surface.
  3. Match the mask aperture size and aperture position with the land pattern.
  4. Refer to "SNT Package User's Guide" for details.

※1. 请注意焊盘模式的宽度 (0.25 mm min. / 0.30 mm typ.).  
 ※2. 请勿向封装中间扩展焊盘模式 (1.30 mm ~ 1.40 mm)。

- 注意
1. 请勿在树脂型封装的下面印刷丝网、焊锡。
  2. 在封装下、布线上的阻焊膜厚度 (从焊盘模式表面起) 请控制在 0.03 mm 以下。
  3. 钢网的开口尺寸和开口位置请与焊盘模式对齐。
  4. 详细内容请参阅 "SNT 封装的应用指南"。

No. PG006-A-L-SD-4.1

TITLE	SNT-6A-A -Land Recommendation
No.	PG006-A-L-SD-4.1
ANGLE	
UNIT	mm
<b>ABLIC Inc.</b>	

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2.4-2019.07



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